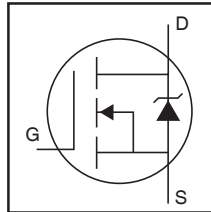


# IRFB3607PbF IRFS3607PbF IRFSL3607PbF

HEXFET® Power MOSFET

## Applications

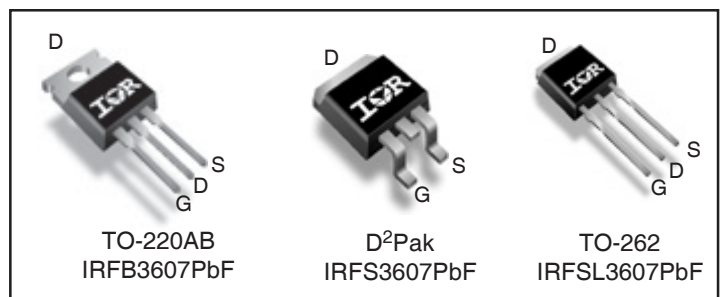
- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits



|                   |      |               |
|-------------------|------|---------------|
| $V_{DSS}$         |      | <b>75V</b>    |
| $R_{DS(on)}$ typ. |      | <b>7.34mΩ</b> |
|                   | max. | <b>9.0mΩ</b>  |
| $I_D$             |      | <b>80A</b>    |

## Benefits

- Improved Gate, Avalanche and Dynamic dv/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability



|          |          |          |
|----------|----------|----------|
| <b>G</b> | <b>D</b> | <b>S</b> |
| Gate     | Drain    | Source   |

## Absolute Maximum Ratings

| Symbol                          | Parameter   | Max.             | Units |
|---------------------------------|---|------------------|-------|
| $I_D @ T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10\text{V}$         | 80 <sup>①</sup>  | A     |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$         | 56 <sup>①</sup>  |       |
| $I_{DM}$                        | Pulsed Drain Current <sup>②</sup>                       | 310              |       |
| $P_D @ T_C = 25^\circ\text{C}$  | Maximum Power Dissipation                               | 140              | W     |
|                                 | Linear Derating Factor                                  | 0.96             | W/°C  |
| $V_{GS}$                        | Gate-to-Source Voltage                                  | $\pm 20$         | V     |
| $T_J$<br>$T_{STG}$              | Operating Junction and Storage Temperature Range        | -55 to +175      | °C    |
|                                 | Soldering Temperature, for 10 seconds (1.6mm from case) | 300              |       |
|                                 | Mounting torque, 6-32 or M3 screw                       | 10lb·in (1.1N·m) |       |

## Avalanche Characteristics

|                              |  |     |    |
|------------------------------|--|-----|----|
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy <sup>③</sup> | 120 | mJ |
| $I_{AR}$                     | Avalanche Current <sup>①</sup>             | 46  | A  |
| $E_{AR}$                     | Repetitive Avalanche Energy <sup>⑤</sup>   | 14  | mJ |

## Thermal Resistance

| Symbol          | Parameter  | Typ. | Max.  | Units |
|-----------------|--|------|-------|-------|
| $R_{\theta JC}$ | Junction-to-Case <sup>⑥</sup>                          | —    | 1.045 | °C/W  |
| $R_{\theta CS}$ | Case-to-Sink, Flat Greased Surface, TO-220             | 0.50 | —     |       |
| $R_{\theta JA}$ | Junction-to-Ambient, TO-220 <sup>⑥</sup>               | —    | 62    |       |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB Mount) , D²Pak <sup>⑥ ⑦</sup> | —    | 40    |       |

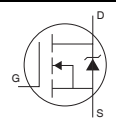
**Static @ T<sub>J</sub> = 25°C (unless otherwise specified)**

| Symbol                               | Parameter                            | Min. | Typ.  | Max. | Units | Conditions  |
|--------------------------------------|--------------------------------------|------|-------|------|-------|---|
| V <sub>(BR)DSS</sub>                 | Drain-to-Source Breakdown Voltage    | 75   | —     | —    | V     | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA                        |
| ΔV <sub>(BR)DSS/ΔT<sub>J</sub></sub> | Breakdown Voltage Temp. Coefficient  | —    | 0.096 | —    | V/°C  | Reference to 25°C, I <sub>D</sub> = 5mA <sup>②</sup>                |
| R <sub>DS(on)</sub>                  | Static Drain-to-Source On-Resistance | —    | 7.34  | 9.0  | mΩ    | V <sub>GS</sub> = 10V, I <sub>D</sub> = 46A <sup>⑤</sup>            |
| V <sub>GS(th)</sub>                  | Gate Threshold Voltage               | 2.0  | —     | 4.0  | V     | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 100μA          |
| I <sub>DSS</sub>                     | Drain-to-Source Leakage Current      | —    | —     | 20   | μA    | V <sub>DS</sub> = 75V, V <sub>GS</sub> = 0V                         |
|                                      |                                      | —    | —     | 250  |       | V <sub>DS</sub> = 60V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125°C |
| I <sub>GSS</sub>                     | Gate-to-Source Forward Leakage       | —    | —     | 100  | nA    | V <sub>GS</sub> = 20V   |
|                                      | Gate-to-Source Reverse Leakage       | —    | —     | -100 |       | V <sub>GS</sub> = -20V  |

**Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)**

| Symbol                     | Parameter   | Min. | Typ. | Max. | Units  | Conditions  |
|----------------------------|---|------|------|------|--|---|
| g <sub>fs</sub>            | Forward Transconductance                                    | 115  | —    | —    | S  | V <sub>DS</sub> = 50V, I <sub>D</sub> = 46A                       |
| Q <sub>g</sub>             | Total Gate Charge   | —    | 56   | 84   | nC   | I <sub>D</sub> = 46A  |
| Q <sub>gs</sub>            | Gate-to-Source Charge                                       | —    | 13   | —    |  | V <sub>DS</sub> = 38V   |
| Q <sub>gd</sub>            | Gate-to-Drain ("Miller") Charge                             | —    | 16   | —    |  | V <sub>GS</sub> = 10V <sup>⑤</sup>                                |
| Q <sub>sync</sub>          | Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> ) | —    | 40   | —    |  | I <sub>D</sub> = 46A, V <sub>DS</sub> = 0V, V <sub>GS</sub> = 10V |
| R <sub>G(int)</sub>        | Internal Gate Resistance                                    | —    | 0.55 | —    | Ω  |   |
| t <sub>d(on)</sub>         | Turn-On Delay Time  | —    | 16   | —    | ns   | V <sub>DD</sub> = 49V   |
| t <sub>r</sub>             | Rise Time   | —    | 110  | —    |  | I <sub>D</sub> = 46A  |
| t <sub>d(off)</sub>        | Turn-Off Delay Time   | —    | 43   | —    |  | R <sub>G</sub> = 6.8Ω   |
| t <sub>f</sub>             | Fall Time   | —    | 96   | —    |  | V <sub>GS</sub> = 10V <sup>⑤</sup>                                |
| C <sub>iss</sub>           | Input Capacitance   | —    | 3070 | —    |  | pF  |
| C <sub>oss</sub>           | Output Capacitance  | —    | 280  | —    | V <sub>DS</sub> = 50V  |   |
| C <sub>rss</sub>           | Reverse Transfer Capacitance                                | —    | 130  | —    | f = 1.0MHz   |   |
| C <sub>oss</sub> eff. (ER) | Effective Output Capacitance (Energy Related) <sup>③</sup>  | —    | 380  | —    | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 60V <sup>③</sup> |   |
| C <sub>oss</sub> eff. (TR) | Effective Output Capacitance (Time Related) <sup>⑥</sup>    | —    | 610  | —    | V <sub>GS</sub> = 0V, V <sub>DS</sub> = 0V to 60V <sup>⑥</sup> |   |

**Diode Characteristics**

| Symbol           | Parameter                                       | Min.   | Typ. | Max.            | Units | Conditions   |
|------------------|---|--|------|-----------------|-------|--|
| I <sub>S</sub>   | Continuous Source Current (Body Diode)          | —  | —    | 80 <sup>①</sup> | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| I <sub>SM</sub>  | Pulsed Source Current (Body Diode) <sup>②</sup> | —  | —    | 310             |       |  |
| V <sub>SD</sub>  | Diode Forward Voltage                           | —  | —    | 1.3             | V     | T <sub>J</sub> = 25°C, I <sub>S</sub> = 46A, V <sub>GS</sub> = 0V <sup>⑤</sup>   |
| dv/dt            | Peak Diode Recovery                             | —  | 27   | —               | V/ns  | T <sub>J</sub> = 175°C, I <sub>S</sub> = 46A, V <sub>DS</sub> = 75V <sup>④</sup>   |
| t <sub>rr</sub>  | Reverse Recovery Time                           | —  | 33   | 50              | ns    | T <sub>J</sub> = 25°C V <sub>R</sub> = 64V,  |
|                  |   | —  | 39   | 59              |       | T <sub>J</sub> = 125°C I <sub>F</sub> = 46A  |
| Q <sub>rr</sub>  | Reverse Recovery Charge                         | —  | 32   | 48              | nC    | T <sub>J</sub> = 25°C di/dt = 100A/μs <sup>⑤</sup>   |
|                  |   | —  | 47   | 71              |       | T <sub>J</sub> = 125°C   |
| I <sub>RRM</sub> | Reverse Recovery Current                        | —  | 1.9  | —               | A     | T <sub>J</sub> = 25°C  |
| t <sub>on</sub>  | Forward Turn-On Time                            | Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD) |      |                 |       |  |

**Notes:**

- ① Calculated continuous current based on maximum allowable junction temperature. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ Limited by T<sub>Jmax</sub>, starting T<sub>J</sub> = 25°C, L = 0.12mH R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 46A, V<sub>GS</sub> = 10V. Part not recommended for use above this value.
- ④ I<sub>SD</sub> ≤ 46A, di/dt ≤ 1920A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 175°C.
- ⑤ Pulse width ≤ 400μs; duty cycle ≤ 2%.
- ⑥ C<sub>oss</sub> eff. (TR) is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- ⑦ C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- ⑧ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- ⑨ R<sub>θj</sub> is measured at T<sub>J</sub> approximately 90°C.

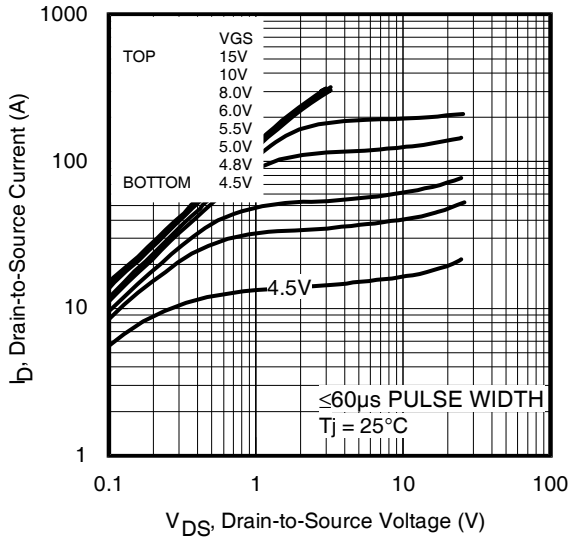


Fig 1. Typical Output Characteristics

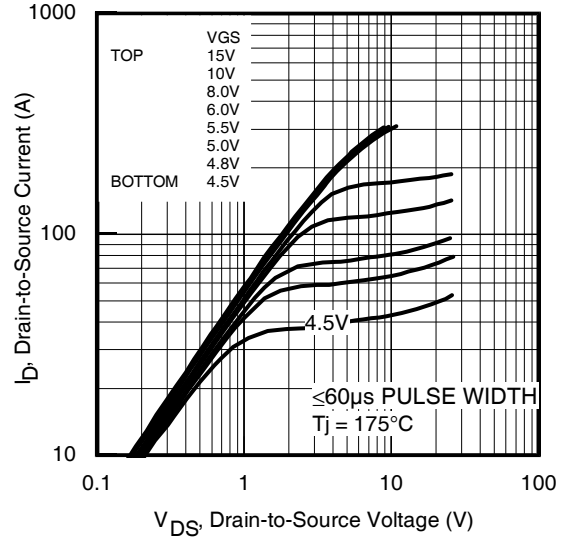


Fig 2. Typical Output Characteristics

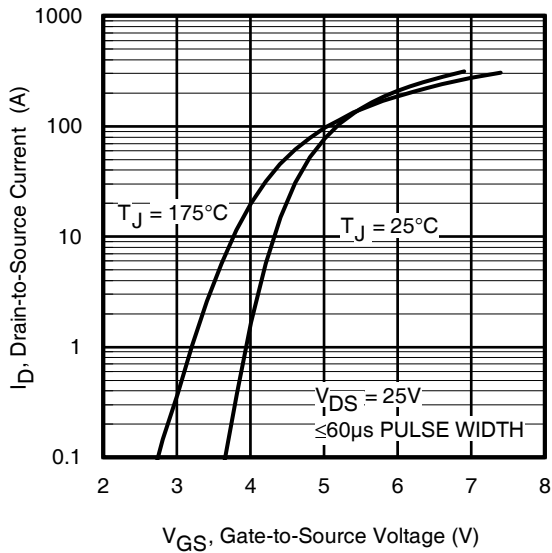


Fig 3. Typical Transfer Characteristics

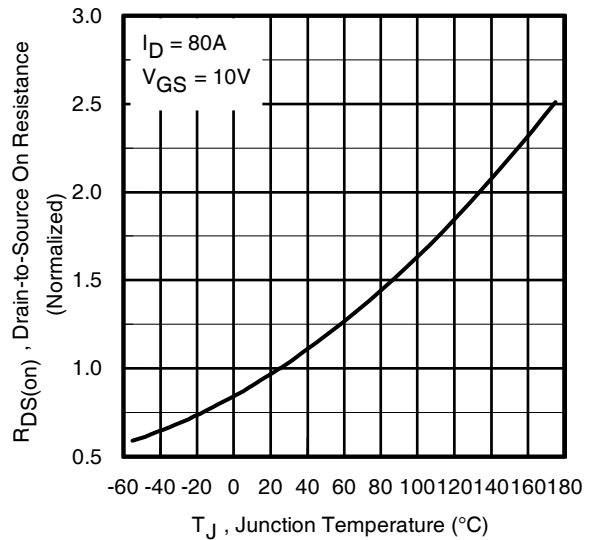


Fig 4. Normalized On-Resistance vs. Temperature

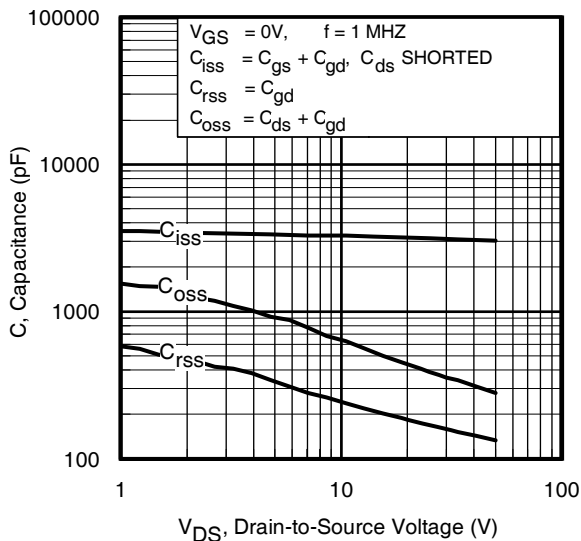


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

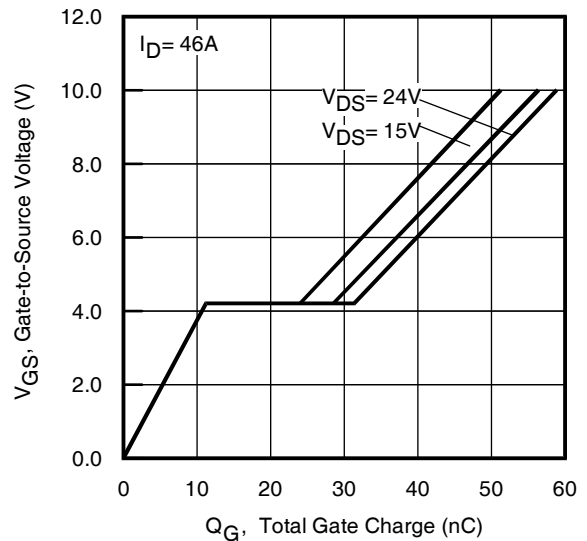


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

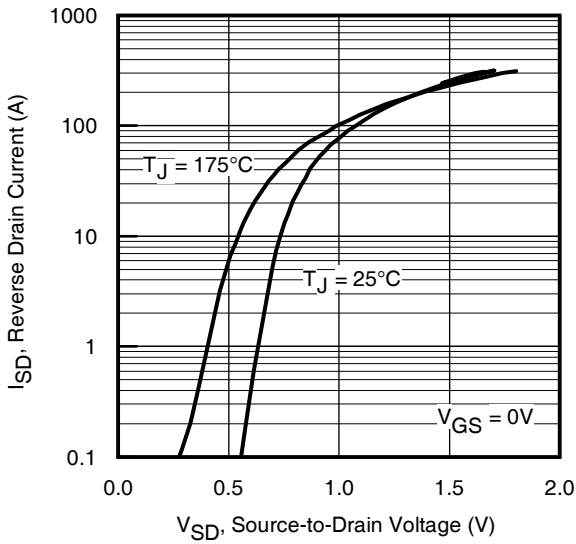


Fig 7. Typical Source-Drain Diode Forward Voltage

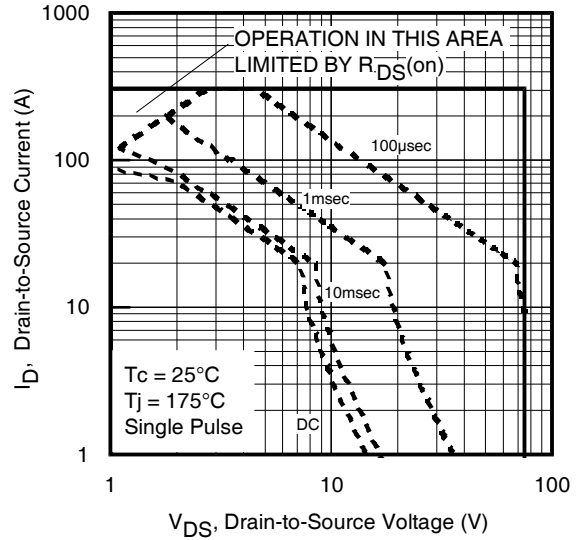


Fig 8. Maximum Safe Operating Area

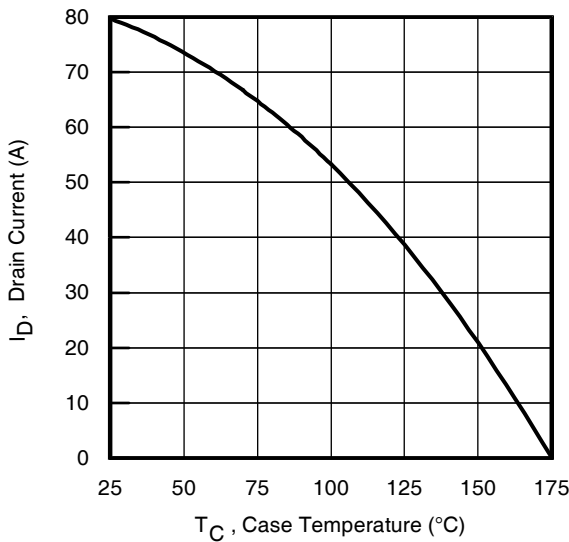


Fig 9. Maximum Drain Current vs. Case Temperature

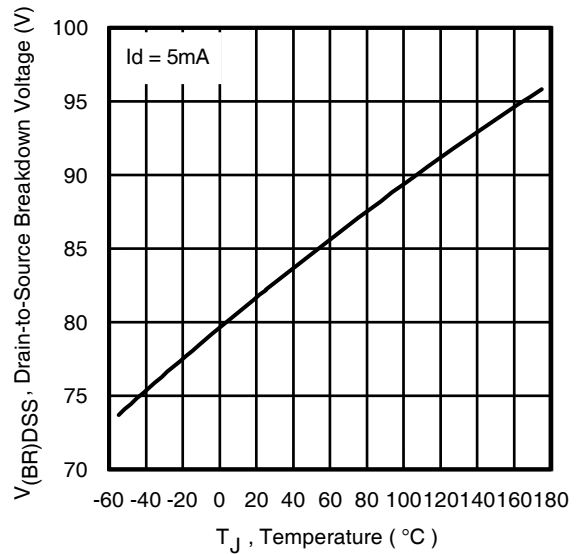


Fig 10. Drain-to-Source Breakdown Voltage

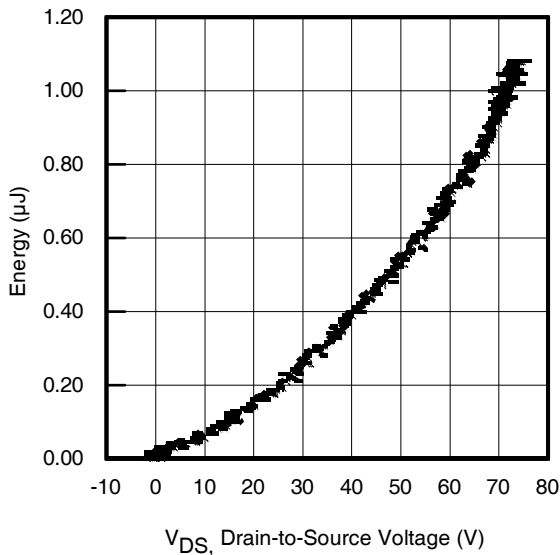


Fig 11. Typical C<sub>OSS</sub> Stored Energy

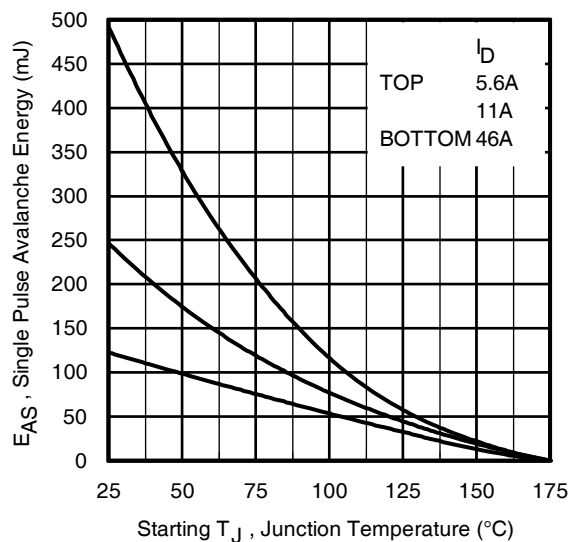


Fig 12. Maximum Avalanche Energy vs. Drain Current

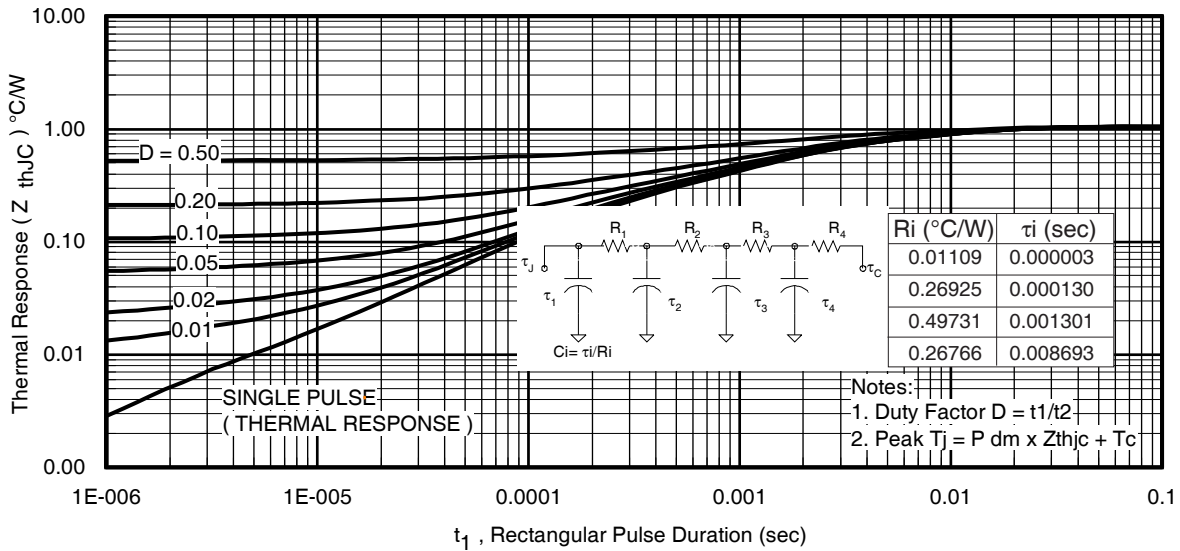


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

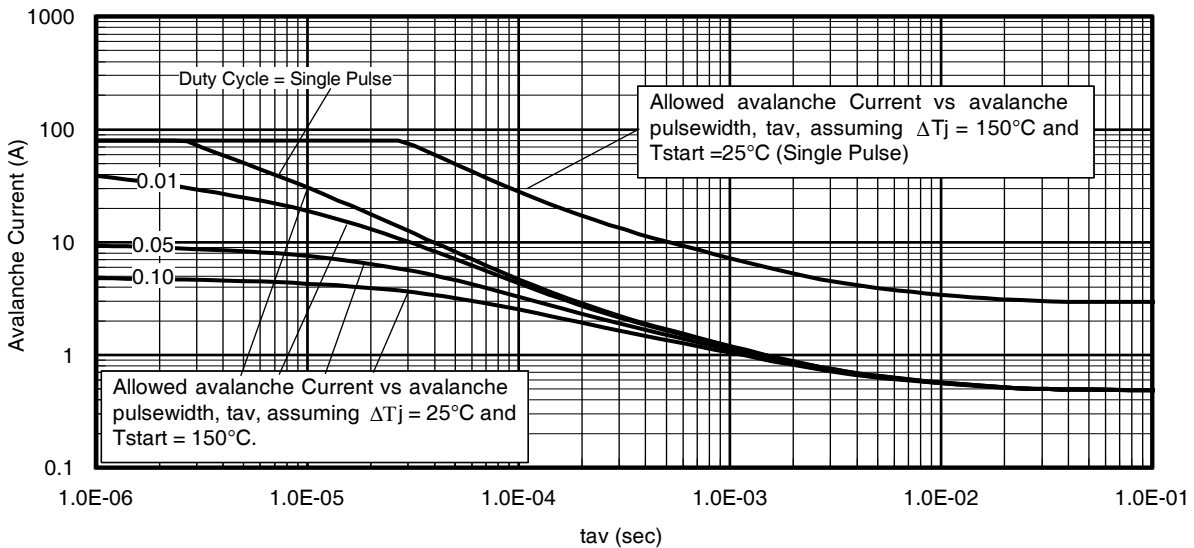


Fig 14. Typical Avalanche Current vs. Pulsewidth

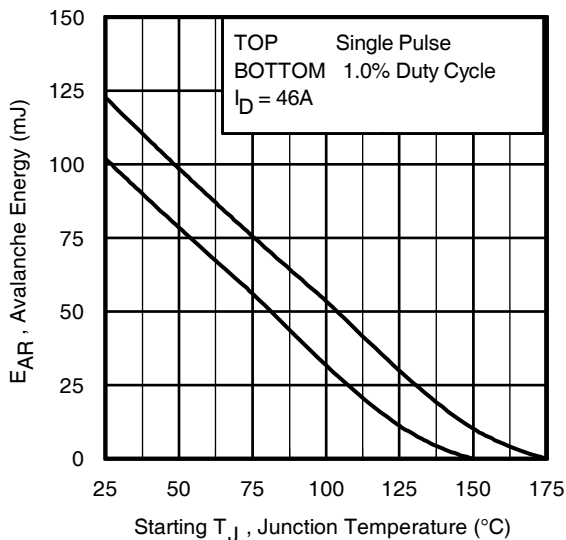


Fig 15. Maximum Avalanche Energy vs. Temperature

**Notes on Repetitive Avalanche Curves, Figures 14, 15:**  
(For further info, see AN-1005 at [www.irf.com](http://www.irf.com))

1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

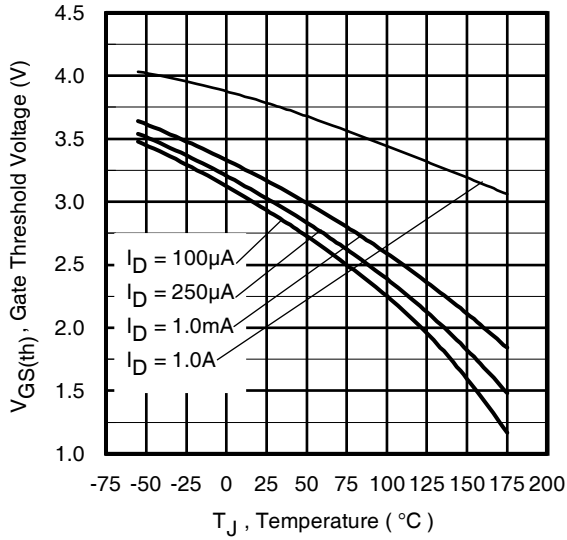


Fig 16. Threshold Voltage vs. Temperature

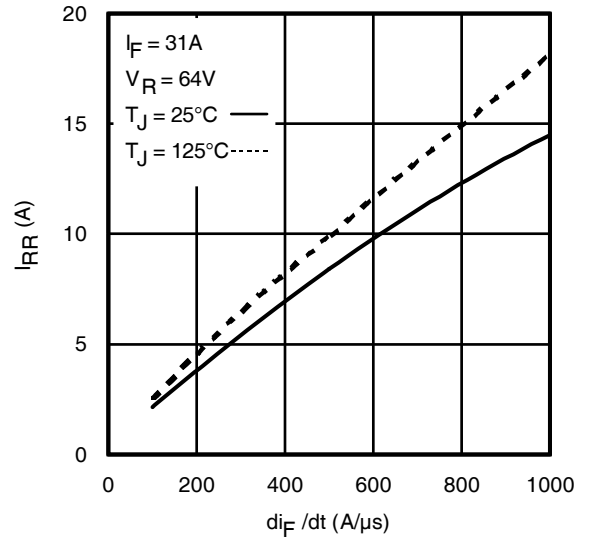


Fig. 17 - Typical Recovery Current vs.  $di_F/dt$

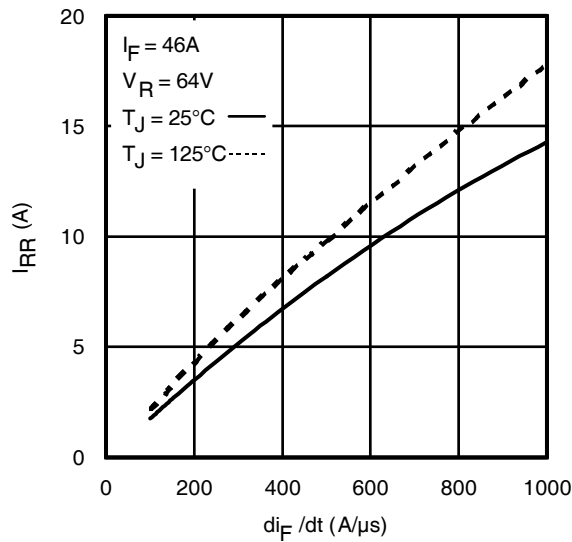


Fig. 18 - Typical Recovery Current vs.  $di_F/dt$

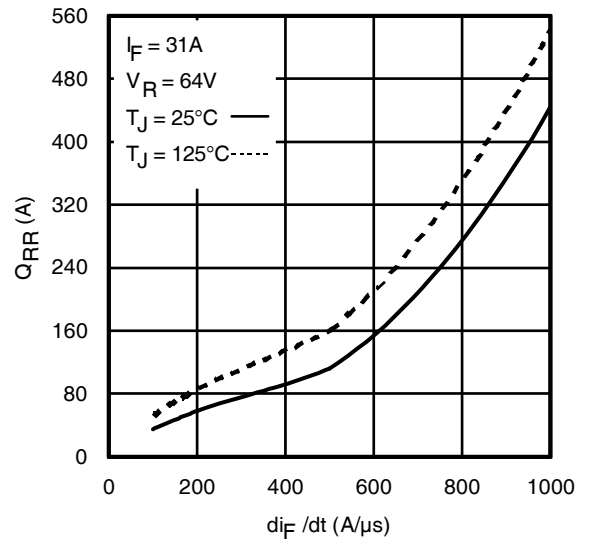


Fig. 19 - Typical Stored Charge vs.  $di_F/dt$

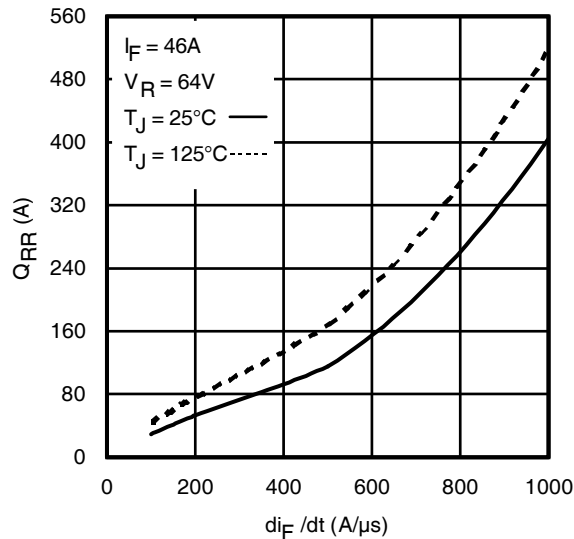


Fig. 20 - Typical Stored Charge vs.  $di_F/dt$



\*  $V_{GS} = 5V$  for Logic Level Devices

**Fig 20. Peak Diode Recovery  $dv/dt$  Test Circuit for N-Channel HEXFET® Power MOSFETs**



**Fig 21a. Unclamped Inductive Test Circuit**



**Fig 21b. Unclamped Inductive Waveforms**



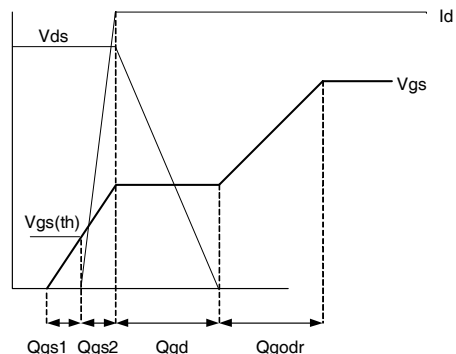
**Fig 22a. Switching Time Test Circuit**



**Fig 22b. Switching Time Waveforms**

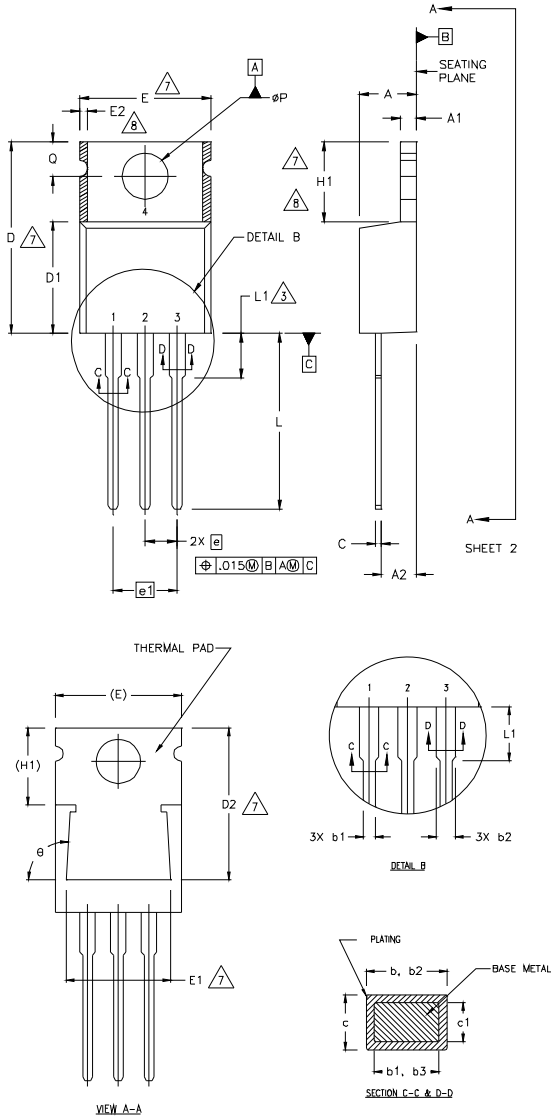


**Fig 23a. Gate Charge Test Circuit**



**Fig 23b. Gate Charge Waveform**

TO-220AB Package Outline (Dimensions are shown in millimeters (inches))



NOTES:

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- 3 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- 4 DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5 DIMENSION b1 & c1 APPLY TO BASE METAL ONLY.
- 6 CONTROLLING DIMENSION : INCHES.
- 7 THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- 8 DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE

IGBTs, CoPACK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER

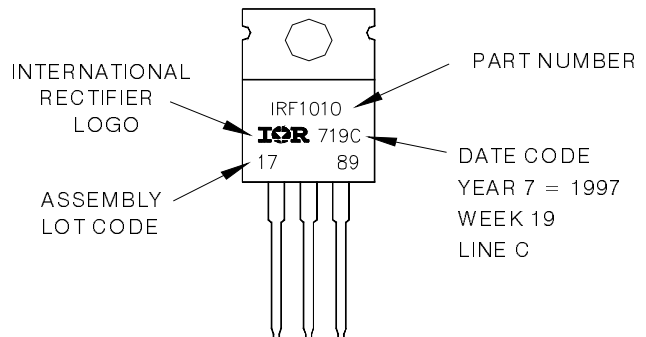
DIODES

- 1.- ANODE/OPEN
- 2.- CATHODE
- 3.- ANODE

| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 3.56        | 4.82  | .140     | .190 |       |
| A1     | 0.51        | 1.40  | .020     | .055 |       |
| A2     | 2.04        | 2.92  | .080     | .115 |       |
| b      | 0.38        | 1.01  | .015     | .040 |       |
| b1     | 0.38        | 0.96  | .015     | .038 | 5     |
| b2     | 1.15        | 1.77  | .045     | .070 |       |
| b3     | 1.15        | 1.73  | .045     | .068 |       |
| c      | 0.36        | 0.61  | .014     | .024 |       |
| c1     | 0.36        | 0.56  | .014     | .022 | 5     |
| D      | 14.22       | 16.51 | .560     | .650 | 4     |
| D1     | 8.38        | 9.02  | .330     | .355 |       |
| D2     | 12.19       | 12.88 | .480     | .507 | 7     |
| E      | 9.66        | 10.66 | .380     | .420 | 4,7   |
| E1     | 8.38        | 8.89  | .330     | .350 | 7     |
| e      | 2.54 BSC    |       | .100 BSC |      |       |
| e1     | 5.08        |       | .200 BSC |      |       |
| H1     | 5.85        | 6.55  | .230     | .270 | 7,8   |
| L      | 12.70       | 14.73 | .500     | .580 |       |
| L1     | -           | 6.35  | -        | .250 | 3     |
| ØP     | 3.54        | 4.08  | .139     | .161 |       |
| Q      | 2.54        | 3.42  | .100     | .135 |       |
| Ø      | 90°-93°     |       | 90°-93°  |      |       |

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"  
**Note:** "P" in assembly line position indicates "Lead-Free"



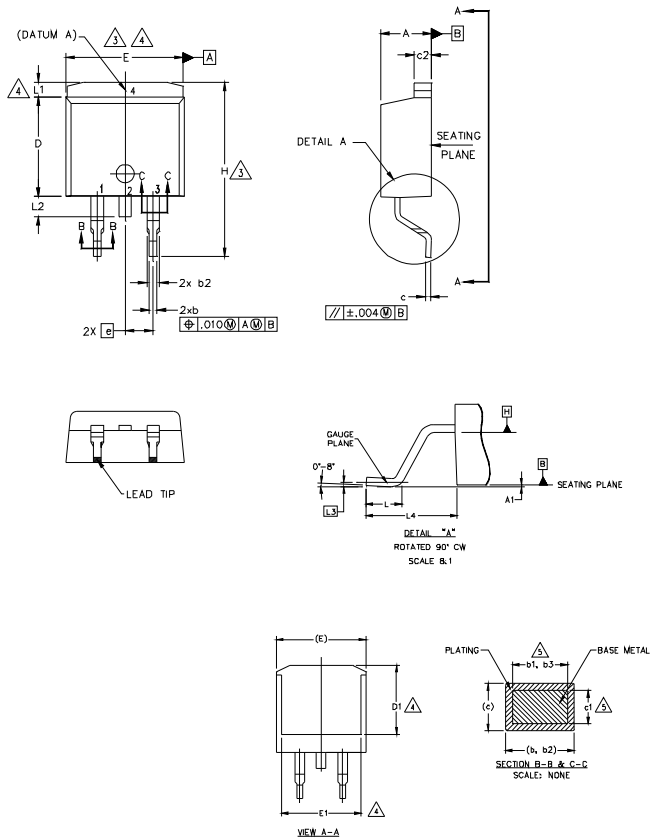
TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>



## D<sup>2</sup>Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)



**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
7. CONTROLLING DIMENSION: INCH.
8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 4.06        | 4.83  | .160     | .190 | 5     |
| A1     | 0.00        | 0.254 | .000     | .010 |       |
| b      | 0.51        | 0.99  | .020     | .039 |       |
| b1     | 0.51        | 0.89  | .020     | .035 |       |
| b2     | 1.14        | 1.78  | .045     | .070 |       |
| b3     | 1.14        | 1.73  | .045     | .068 | 5     |
| c      | 0.38        | 0.74  | .015     | .029 | 5     |
| c1     | 0.38        | 0.58  | .015     | .023 |       |
| c2     | 1.14        | 1.65  | .045     | .065 |       |
| D      | 8.38        | 9.65  | .330     | .380 | 3     |
| D1     | 6.86        | -     | .270     | -    | 4     |
| E      | 9.65        | 10.67 | .380     | .420 | 3,4   |
| E1     | 6.22        | -     | .245     | -    | 4     |
| e      | 2.54 BSC    |       | .100 BSC |      | 4     |
| H      | 14.61       | 15.88 | .575     | .625 |       |
| L      | 1.78        | 2.79  | .070     | .110 |       |
| L1     | -           | 1.65  | -        | .066 |       |
| L2     | 1.27        | 1.78  | -        | .070 |       |
| L3     | 0.25 BSC    |       | .010 BSC |      |       |
| L4     | 4.78        | 5.28  | .188     | .208 |       |

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2, 4.- DRAIN
- 3.- SOURCE

IGBTs, CoPACK

- 1.- GATE
- 2, 4.- COLLECTOR
- 3.- EMITTER

DIODES

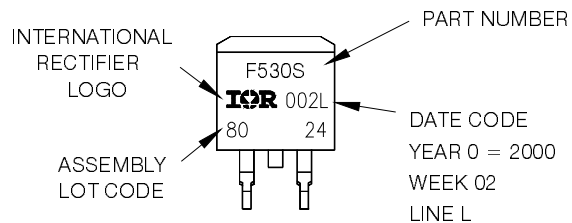
- 1.- ANODE \*
- 2, 4.- CATHODE
- 3.- ANODE

\* PART DEPENDENT.

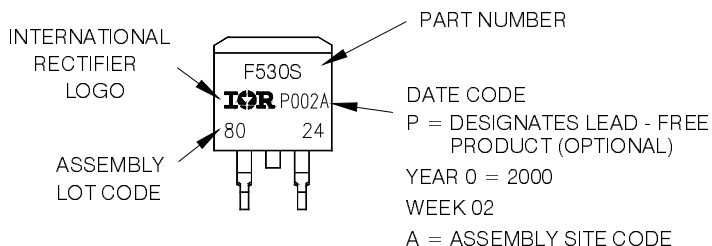
## D<sup>2</sup>Pak (TO-263AB) Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH  
LOT CODE 8024  
ASSEMBLED ON WW 02, 2000  
IN THE ASSEMBLY LINE "L"

Note: "P" in assembly line position  
indicates "Lead - Free"



OR

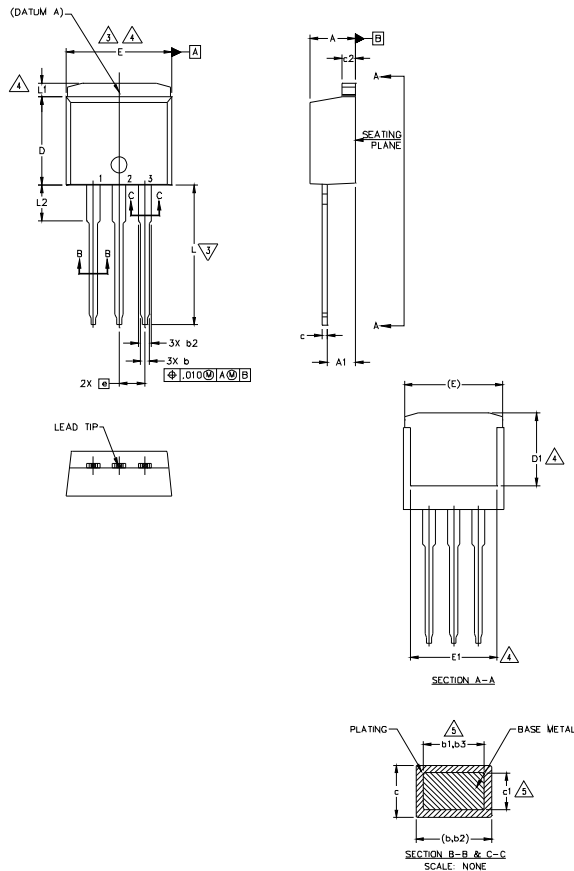


Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

# IRFB/S/SL3607PbF

## TO-262 Package Outline

Dimensions are shown in millimeters (inches)



**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [0.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
5. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
6. CONTROLLING DIMENSION: INCH.
7. OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

| SYMBOL | DIMENSIONS  |       |        |      | NOTES |
|--------|-------------|-------|--------|------|-------|
|        | MILLIMETERS |       | INCHES |      |       |
|        | MIN.        | MAX.  | MIN.   | MAX. |       |
| A      | 4.06        | 4.83  | .160   | .190 |       |
| A1     | 2.03        | 3.02  | .080   | .119 |       |
| b      | 0.51        | 0.99  | .020   | .039 |       |
| b1     | 0.51        | 0.89  | .020   | .035 | 5     |
| b2     | 1.14        | 1.78  | .045   | .070 |       |
| b3     | 1.14        | 1.73  | .045   | .068 | 5     |
| c      | 0.38        | 0.74  | .015   | .029 |       |
| c1     | 0.38        | 0.58  | .015   | .023 | 5     |
| c2     | 1.14        | 1.65  | .045   | .065 |       |
| D      | 8.38        | 9.65  | .330   | .380 | 3     |
| D1     | 6.86        | -     | .270   | -    | 4     |
| E      | 9.65        | 10.67 | .380   | .420 | 3,4   |
| E1     | 6.22        | -     | .245   | -    | 4     |
| e      | 2.54        | BSC   | .100   | BSC  |       |
| L      | 13.46       | 14.10 | .530   | .555 |       |
| L1     | -           | 1.65  | -      | .065 | 4     |
| L2     | 3.56        | 3.71  | .140   | .146 |       |

**LEAD ASSIGNMENTS**

**HEXFET**

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

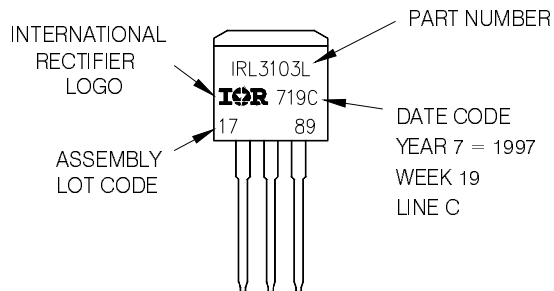
**IGBTs, CoPACK**

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

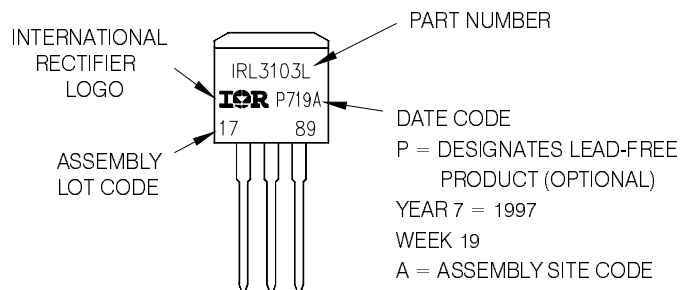
## TO-262 Part Marking Information

EXAMPLE: THIS IS AN IRL3103L  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 1997  
 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"



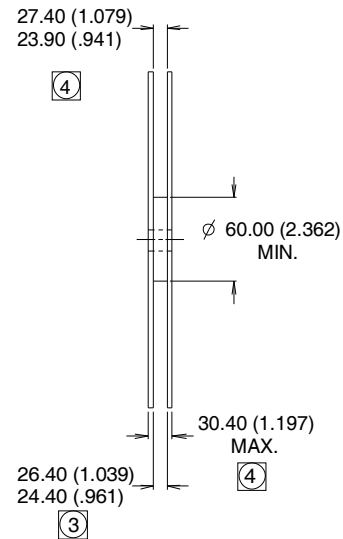
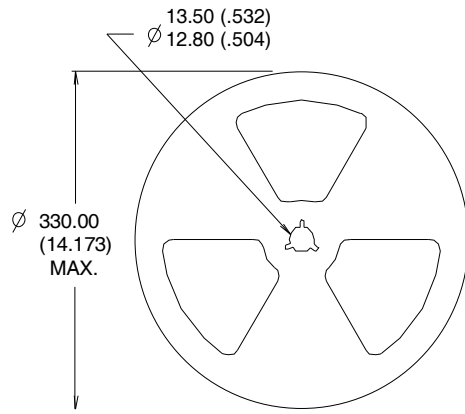
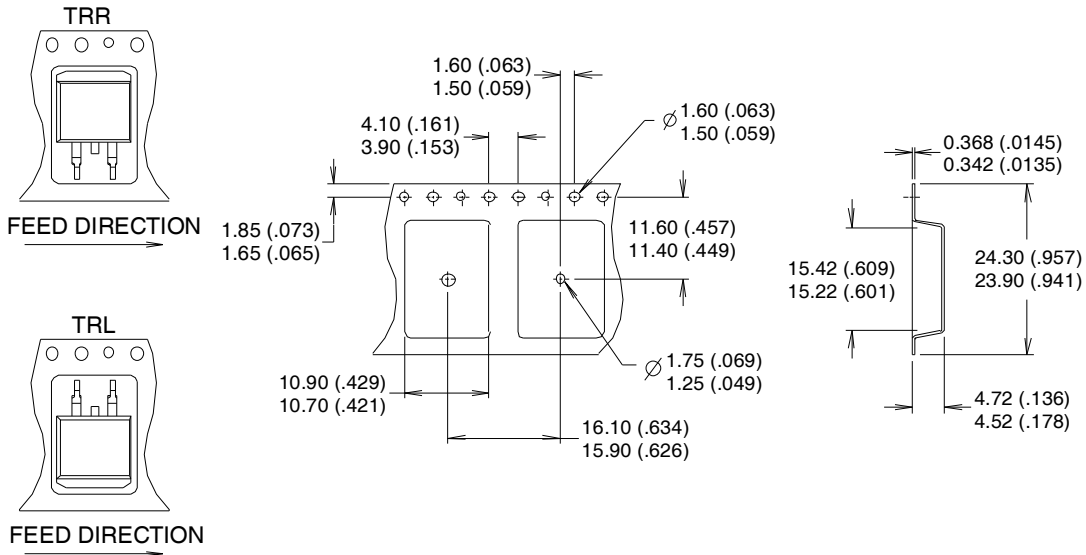
OR



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information

Dimensions are shown in millimeters (inches)



NOTES :

1. CONFORMS TO EIA-418.
2. CONTROLLING DIMENSION: MILLIMETER.
- ③ DIMENSION MEASURED @ HUB.
- ④ INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

单击下面可查看定价，库存，交付和生命周期等信息

[>>Infineon Technologies\(英飞凌\)](#)